## GaAs Pseudomorphic HEMT and MESFET Chips

August 2006 - Rev 03-Aug-06



### **CF001 Series**

## CF001 Series GaAs Pseudomorphic HEMT and MESFET Chips

❑ Super Low Noise: 0.8 dB at 12 GHz

High Gain: Usable to 44 GHz

**P**<sub>1dB</sub> Power: Up to +19 dBm

Active Layers Include: Pseudomorphic HEMT, Epitaxial and Ion Implanted

**U** Wafer Qualification Procedure

Customer Wafer Selection Available

#### Celeritek CF001 Series Chips

Celeritek CF001 Series chips are GaAs-based transistors which include the CF001-01. CF001-02 and CF001-03 models. They are 300 µm gate width. sub-half-micron gate length GaAs devices with Celeritek's proprietary Silicon Nitride passivation.

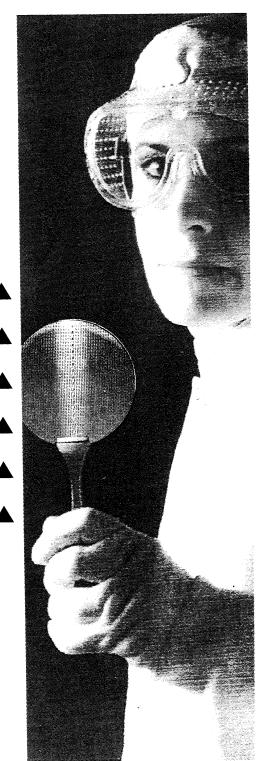
Celeritek's Wafer Qualification Procedure for CF001 Series FETs consists of DC. RF and reliability testing of both individual die and generic 6 to 18 GHz amplifier modules.

The CF001-01 provides high gain up to 26 GHz. It is suitable for general purpose and driver amplifier applications with up to  $\pm 19$  dBm power from a single FET. These devices can also be used in oscillator applications.

The CF001-03 model is Celeritek's state-of-the-art low noise and high associated gain GaAs Pseudomorphic HEMT device. It is suitable for narrow and wide band low noise and high gain amplifiers up to 40 GHz. Its rugged construction allows it to withstand the same input power as conventional MESFETs.

All CF001 Series devices are available in chip form and are suitable for airborne, shipboard and ground-based equipment. Screening includes MIL-STD-750 Class B. Class S and commercial screening. These devices are also available in packaged form. Please consult the CFB001 Series and CFA001 Series data sheets or contact the factory for further information.





Mimix Broadband, Inc., 10795 Rockley Rd., Houston, Texas 77099 Tel: 281.988.4600 Fax: 281.988.4615 mimixbroadband.com

# GaAs Pseudomorphic HEMT and MESFET Chips



**CF001** Series

August 2006 - Rev 03-Aug-06

## **CF001 Series GaAs Chips**

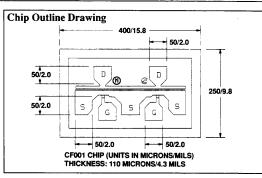
Specifi	cations ( $T_A = 25^{\circ}C$ )	C	F001-	01	C	F001-	02	CF001-03				
Active L	_ayer	lon Implanted			Epitaxial			Pseudomorphic HEMT				
Symbol	Parameters and Conditions	Frequency (GHz) Units		Min	Тур Мах		Min	Тур	Max	Min	Тур	Max
NFopt	Optimum Noise Figure $V_{DS} = 3.0 \text{ V}, I_{DS} = 15 \text{ mA}$	dB		1.6	2.4		1.2	1.8		0.8	1.2	
Ga	Gain at NF <sub>opt</sub> V <sub>DS</sub> = 3.0 V, I <sub>DS</sub> = 15 mA	12.0	dB	7.5	8.5		8.5	9.5		9.5	10.5	
S <sub>21</sub>   <sup>2</sup>	50 Ohm Insertion Gain $V_{DS} = 6.0 \text{ V}, I_{DS} = 40 \text{ mA}$	dB dB dB		13.0 9.5 6.0			14.0 10.5 7.0			15.0 11.5 8.0		
P <sub>1dB</sub>	Power Output @ 1 dB GC $V_{DS}$ = 6.0 V, $I_{DS}$ = 40 mA	12.0	dBm		19.0			17.0			17.0	
9 <sub>m</sub>	Transconductance $V_{DS} = 3.0 V, V_{GS} = 0 V$	mS		60			75			90		
IDSS	Drain Current V <sub>DS</sub> = 3.0 V, V <sub>GS</sub> = 0 V	mA	40	60	120	30	60	120	30	60	120	
۷ <sub>P</sub>	Pinchoff Voltage V <sub>DS</sub> = 3.0 V, I <sub>DS</sub> = 1 mA	Volts	-0.7	-1.3	-2.5	-0.5	-1.3	-2.5	-0.5	-1.3	-2.5	
bv <sub>gd</sub>	Breakdown Voltage, Gate-D I <sub>GD</sub> = 100 μA	Volts	-5.5	-8.0		-5.5	-8.0		-5.5	-8.0		
R <sub>th</sub>	Thermal Resistance		150			150			150			

#### Absolute Maximum Ratings

Parameter	Symbol	Ratings
Drain-Source Voltage	V <sub>DS</sub>	8V
Gate-Source Voltage	V <sub>GS</sub>	-5V
Drain Current	IDS	IDSS
Continuous Dissipation	PT	800 mW
Channel Temperature	тсн	175°C
Storage Temperature	TSTG	-65°C to +175°C

Typical Noise Parameters - CF001-03 V <sub>DS</sub>	= 3.0 V, I <sub>DS</sub> = 15 mA
---	----------------------------------

Frequency (GHz)	NF opt (dB)	Ga (dB)	Gamr (Mag)	na opt (Ang)	Rn/50
2.0	0.35	19.4	0.85	9	0.69
4.0	0.43	16.2	0.76	19	0.48
6.0	0.51	14.0	0.70	35	0.38
8.0	0.60	12.4	0.65	54	0.31
10.0	0.70	11.4	0.60	73	0.26
12.0	0.80	10.8	0.55	90	0.21
14.0	0.91	10.2	0.52	107	0.17
16.0	1.02	9.8	0.49	123	0.12
18.0	1.14	9.3	0.48	142	0.09
20.0	1.27	8.8	0.49	162	0.06
22.0	1.40	8.2	0.53	-179	0.05
24.0	1.54	7.6	0.58	-165	0.05
26.0	1.68	7.0	0.58	-161	0.08



### **Die Attach and Bonding Procedures**

**Die Attach:** Conductive epoxy or eutectic die attach is recommended. For eutectic die attach: Preform: AuSn (80% Au, 20% Sn); Stage Temperature: 290°C,  $\pm$ 5°C; Handling Tool: Tweezers; Time: 1 min or less. **Wire Bonding:** Wire Size: 0.7 to 1.0 mil in diameter (pre-

stressed); Thermocompression bonding is preferred over thermosonic bonding. For thermocompression bonding: Stage Temperature: 250°C; Bond Tip Temperature: 150°C; Bonding Tip Pressure: 18 to 40 gms depending on size of wire.

## CELERITEK\_

[ 154 ]

### Mimix Broadband, Inc., 10795 Rockley Rd., Houston, Texas 77099 Tel: 281.988.4600 Fax: 281.988.4615 mimixbroadband.com

Page 2 of 4

# GaAs Pseudomorphic HEMT and MESFET Chips

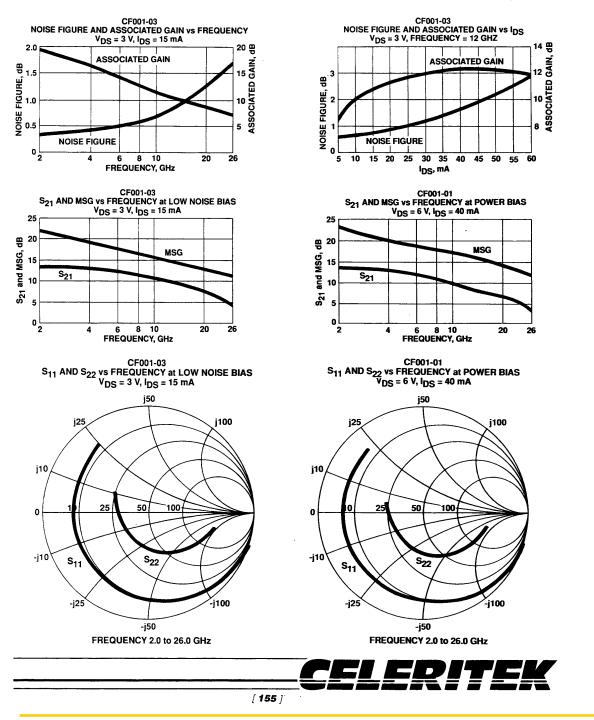
August 2006 - Rev 03-Aug-06



### **CF001** Series

## **CF001 Series GaAs Chips**

Typical Performance ( $T_A = 25^{\circ}C$ )



### Mimix Broadband, Inc., 10795 Rockley Rd., Houston, Texas 77099 Tel: 281.988.4600 Fax: 281.988.4615 mimixbroadband.com

Page 3 of 4

**CF001** Series

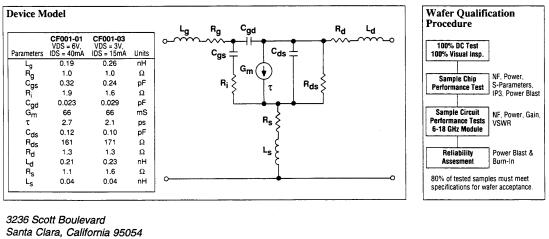
August 2006 - Rev 03-Aug-06

## **CF001 Series GaAs Chips**

Typical Scattering Parameters, Common Source (S-Parameters Include Bonding Wire Parasitics)

Frequency	S <sub>11</sub>		S <sub>21</sub>				S <sub>12</sub>		S <sub>22</sub>		к	MSG
(GHz)	(Mag)	(Ang)	(dB)	(Mag)	(Ang)	(dB)	(Mag)	(Ang)	(Mag)	(Ang)		(dB)
2.0	0.98	-24	13.2	4.56	156	-33.2	0.02	73	0.53	-10	0.27	23.2
4.0	0.93	-51	12.7	4.31	136	-27.7	0.04	62	0.50	-25	0.34	20.2
6.0	0.88	-72	11.7	3.83	118	-25.3	0.05	51	0.48	-35	0.46	18.5
8.0	0.84	-98	10.8	3.47	100	-23.8	0.06	38	0.43	-51	0.55	17.3
10.0	0.79	-122	9.5	2.99	82	-24.1	0.06	23	0.38	-68	0.83	16.8
12.0	0.79	-140	8.4	2.64	67	-23.3	0.07	18	0.38	-83	0.79	15.9
14.0	0.78	-154	7.6	2.41	55	-23.2	0.07	10	0.39	-93	0.86	15.4
16.0	0.78	-166	7.1	2.27	44	-22.5	0.07	5	0.36	-101	0.90	14.8
18.0	0.77	178	6.7	2.16	30	-21.8	0.08	-2	0.32	-113	0.93	14.2
20.0	0.76	159	6.2	2.04	15	-21.0	0.09	-13	0.27	-131	0.95	13.6
22.0	0.79	141	5.2	1.82	-2	-20.8	0.09	-20	0.27	-163	0.91	13.0
24.0	0.78	132	3.7	1.52	-13	-20.9	0.09	-21	0.30	176	1.12	12.3
26.0	0.81	129	2.3	1.31	-21	-20.5	0.09	-19	0.39	168	0.91	11.4

CF001-03 at	Low Noi	se Bias							V <sub>DS</sub> = 3 V, I <sub>DS</sub> = 15 n				
Frequency S <sub>11</sub>		S <sub>21</sub>			(dD)	S <sub>12</sub>			2 (Ang)	к	MSG (dB)		
(GHz)	(Mag)	(Ang)	(dB)	(Mag)	(Ang)	(dB)	(Mag)	(Ang)	(Mag)	(Ang)			
2.0	0.99	-24	13.2	4.57	160	-30.8	0.03	76	0.57	-16	0.08	22.0	
4.0	0.95	-50	12.9	4.43	140	-25.0	0.06	61	0.54	-32	0.16	19.0	
6.0	0.90	-69	12.1	4.02	124	-22.7	0.07	50	0.52	-43	0.25	17.4	
8.0	0.85	-93	11.5	3.76	106	-21.0	0.09	35	0.46	-60	0.33	16.2	
10.0	0.79	-118	10.6	3.38	88	-20.5	0.09	20	0.40	-79	0.47	15.5	
12.0	0.78	-139	9.8	3.08	73	-19.6	0.10	10	0.38	-95	0.46	14.7	
14.0	0.77	-156	9.1	2.85	60	-19.4	0.11	1	0.35	-107	0.52	14.2	
16.0	0.76	-171	8.6	2.69	46	-18.6	0.12	-8	0.31	-120	0.55	13.6	
18.0	0.77	171	8.0	2.52	32	-18.2	0.12	-18	0.25	-142	0.59	13.1	
20.0	0.76	152	7.4	2.35	16	-17.9	0.13	-29	0.22	-171	0.64	12.6	
22.0	0.79	136	6.3	2.05	0	-17.7	0.13	-38	0.26	158	0.60	12.0	
24.0	0.77	129	4.7	1.72	-10	-18.3	0.12	-39	0.30	145	0.78	11.5	
26.0	0.80	125	3.6	1.52	-17	-18.2	0.12	-39	0.36	145	0.70	10.9	





Mimix Broadband, Inc., 10795 Rockley Rd., Houston, Texas 77099 Tel: 281.988.4600 Fax: 281.988.4615 mimixbroadband.com Page 4 of 4